

Search Notes



Application/Control No.

10/752,010

Examiner

Anh Q. Tran

Applicant(s)/Patent under
Reexamination

SEIKE, TOSHIMICHI

Art Unit

2819

SEARCHED

Class	Subclass	Date	Examiner
326	21 1 27	4/12/05	AT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR